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Application/Control No.	Applicant(s)/Patent under Reexamination VAN DEN MEERAKKER ET AL.			
10/535,070				
Examiner	Art Unit	•		
Mahmoud Dahimene	1765			

SEARCHED						
Class	Subclass	Date	Examiner			
216	56	8/15/2007	MD			
216	13	8/15/2007	MD			
216	49	8/15/2007	MD			
205	324	8/15/2007	MD			
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INTERFERENCE SEARCHED					
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56	8/15/2007	MD			
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SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
EAST Search (US-PGPUB, USPAT, USOCR, EPO, JPO, Derwent, IBM-TDB) Search notes attached.	8/15/2007	MD
Inventor search	8/15/2007	MD
NPL search	8/15/2007	MD
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